MANUFACTURE OF THIN FILM MAGNETIC HEAD

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Abstract

PURPOSE: To raise the reliability, and also, to obtain the high density by forming a conductor coil by embedding a metallic film into the groove of an insulating film which is formed in advance, so that insulating layer can be filled exactly between coil wires.

CONSTITUTION:An insulating film 2 is formed by a prescribed film thickness on a substrate 1, and a photoresist pattern 3 is formed thereon. Subsequently, by using the photoresist pattern 3 as a mask material, a groove 20 is formed on the insulating film 2 by dry method. This groove 20 is the same pattern as a pattern of a conductor coil. Thereafter, the photoresist is eliminated by etching, and on the whole surface of the insulating film 2, a plating surface 4 is formed. A metallic film 5 which becomes the conductor coil is formed on its whole surface by a plating method, and thereafter, its whole surface is eliminated to the insulating layer formed part by an etch-back method, and a coil pattern is formed. In such a way, the metallic film 5 is formed in the groove 20 without filling a resin between the coils, thereafter, the generation of an air-foam, based on the fluidity failure of the resin can be prevented.

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明 椒 卷

1. 雅明の名称 薄膜磁気ヘッドの製造方法

- 2. 特許請求の範囲

あらかじめ的記憶練頤に前記導体コイル形状 に相当する脚を前記パターンと例ーパターンで 形成する課パターン形成工程と、

前記導体コイルパターンのコイル机互関が絶 稼されるように前記得内に当該導体コイルとな る金属を充奨して前記導体コイルパターンを形 成するコイルパターン形成工程と、

当該導体コイルパターンを有する絶放膜上に 第2の絶縁腰を形成する絶縁膜形成工程と、

- 2. 特許請求の範囲第1項において、上記識パターン形成工程における溝の中及び当該牌が設けられていない絶縁吸上に導体コイルとなる金属の酸を積滑して形成し、 大いで上記導体コイルパターンのコイル相互間が絶縁されるように、前記金属膜を切削またはエツチングして導体コイルパターンを形成することにより、
 - 前記談内に導体コイルとなる金属を充塡して 上記導体コイルパターンを形成することを特徴 とする薄膜磁気ヘッドの製造方法。
- 3. 特許請求の範則第1項において、上記識パターン形成工程における牌の形成を、上記絶林膜上にフオトレジストのパターンを形成し、該フオトレジストパターンをマスク材にして、当該絶赦膜上に牌を形成することにより行うものであることを特徴とする海膜は気ヘンドの製造方法。
- 3. 発明の辞報な説明

〔産業上の利用分野〕

本現明は辞膜磁気ヘッドの製造法に係り、特に

難膜磁気ヘッドのコイル及び絶数説の形成に関する。

〔從来の技術〕

従来の磁気デイスク製図用移版磁気ヘッドは、 月経エレクトロニクス。1980年7月7日号、 1.10頁から111頁に記述されているように、 夢体コイルをめつき独により形成し、絶隸蹶を、 有機樹脂であるフオトレジストを熱硬化したもの で形成している。このような磁気ディスク装御用 群膜磁気ヘツドにおいて、高密度磁気配線を達成 するためには、限られた部分に高密度なコイルを 形成する必要がある。コイルの高密度を選成する には、たとえば、多者のコイルの各巻のスペース . 御の距離が2μm以下となるような微細な構造が 必要である。この構成の場合、絶紋膜としてフォ トレジストを硬化させたものを使用しているため、 その機能の熱流動性等の性質により、コイル各巻 間に形成されたスペース部に樹脂が充塡され、辞 瞑磁気ヘツドが構成されている。

しかしながら、フオトレジストを硬化した膜は

起こす。 したがつて、上記従来技術では製面を平 坦化する工船が必要となり、工器が複雑となると、 いう問題がある。

本発明の目的は、コイル線関に絶熱層が確実に 充壌できることにより信頼性が高く、かつ、高密 度化された薄膜磁気ヘシドを簡易な工程で製造す ることができる方法を提供することにある。

【問題点を解決するための手段】

 耐感性が思いという問題がある。

耐熱性を向上させた絶縁酸としてポリイミド系 樹脂を用いた何が、アイ・イー・イー・トランザクション オン マグネチックス、エムエージー15, 第1616頁~第1618页 (1979年) (IEEE Trans. Rago , MAG-15, 1616~1618 (1979)) に示されている。

〔発明が解決しようとする問題点〕

しかし、本発明者らが検討したところ上記従来 技術は、コイルの高物度化に対する配慮がされて おらず、コイルのスペース間に気泡なく絶縁何で あるポリイミド系樹脂を充填することは困難とな る。樹脂の流動性が悪いためである。したがつて、 充塊残りによる絶縁樹内の気泡により、磁気ヘツ ドの僧観性を低下するという問題があつた。

また、コイル及びコイル間に絶縁層を形成する ため、形成した絶縁層の投面にコイルの良差を原 因とする絶縁層の凹凸が生じ、そのままでは、そ の上部に形成する磁性膜の磁気特性の劣化を引き

行する絶縁膜上に第2の絶敏膜を形成する絶縁膜 形成工程とを備えてなることを特徴とする裸膜磁 気ヘッドの製造力法である。

(作用)

上記本発明によれば、あらかじめ形成してある 絶棘膜の溝の中へ金属膜を埋め込んで導体コイル を形成することにより、コイル間の絶縁膜中に気 泡のない蔕膜磁気へ少ドを作成することができる。

また、導体コイルを形成した後、その上に絶縁 談を形成する場合に、その面を平坦化できるので、 塗布した絶縁膜の製面の凹凸を小さくすることが でき、 次工程でその上に形成される磁性膜の特性 を食好なものに保つことができる。

(突施例)

図面を用いて、本類明に係る突旋的について説明する。第1図は、本発明における導体コイルの形成に関する工程の機略を示したものである。例においては、磁気ヘッドの断面図を示す。なお、説明上、基板上に形成されている磁性概等は、図面上の基板1に含まれるものとし、導体コイル及

び選体コイルの埋め込まれる絶数別を示してある。 工程は次の順序に従う。

- (1) 基板1上に越敏膜2を所定膜厚形成する (第 1 図 (1))。
- (2) 絶缺数 2 上にフオトレジストパターン3 を形成する。この絶縁数として行機材源又は無機概を使用することができる(第1 図(2))。
- (3) フオトレジストパターン3 をマスク材にして ドライ法で絶縁限2 上に海2 0 を形成する(第 1 図 (3))。この海は専体コイルのパターン と阿一のパターンとなるように形成する。

フオトレジストとそのエツチングにより滞 20を所望の形成(大きさ、高さ、灰さ等)に することができる。機械的加工により降20を 形成することもできるが、それでは微細なパタ ーンを形成する上で十分でない。よつて通常は エッチング加工が望ましい。

- (4) フオトレジストをエッチング除去する (第1 間 (4))。
- (5) 絶数版2表面全面にめつき下地膜4を形成す

a (111 194 (5));

- (6) 全面にめつき法で導体コイルとなる金属膜5を形成する(第1図(6))。これにより、課20中を含み絶縁限上すべてに金属膜が形成されるとともに、その表面の凹凸は絶数膜の凹凸に比較して小さくなり、平坦になる。全面に金属膜5を形成するのは、次の理由による。離20内に限定して金属膜を形成することもできるが、それは通常壁しい。そこで、後述をいって、近常壁しい。そこで、後述をいって、近端をいって、が、それは通常壁と形成し、この金属膜を形成し、この金属膜をいって、シェンを形成するようにした。
- (7) この全面をエンチバック法で絶験層形成部分まで除去する。かつ海の上部に形成されている 海体の接続部分を除去して各導体間が金属膜で つながつていないようにし、コイルパターンを 形成する(第1 図(7))。
- (8) このようにして形成した導体コイル上に絶録 数21を形成して、導体コイル形成工程を終了 する(第1回(8))。

以上の工程によれば、めつきした金属機関(コイル間)に横原を充填させず、調20内に金属膜を形成しているために、横崩の流動性不良に基づく気泡の巻き込み等を防止できる。

第2回は、碁板1上に絶縁限2として有機樹脂

次に具体的な実施例について説明する。

であるポリイミド系樹脂を形成した突旋例を示す (第2関(2))。ポリイミド系樹脂として、 PIQ(ポリイミドイソインドロキナソリンジカン 商品名。日立化成株式会社)を用いた。次いで、ドライ法を加いてコスを形成する海を必ずる。ここで、ドライ法とは、プラズとの手法がよりはられる。いずれの方法についても、存在とよりけられる。いずれの方法についても、存在というながなる。とかできるという特徴がある。

第2.図(1)は、装板1上にFJQからなる絶 練腹を形成している。次に、(2)に示すように フオトレジストパターン3を形成する。ここに用いられるフオトレジストとしては、パターン精度の良いことから、ノボラツク系ポジ型のフオトレジストであるマイクロポジツト1300 (商品名。シプレイフアースト株式会社)を使用することができるが、このフオトレジストパターンの所面形状では絶縁膜2表面に近い方が斬の広い台形になる。

このようにして形成したフオトレジストバターン3をマスクとして、ドライ油でPIQをエッチングする。この時のエッチング決としては、Ozガスを用いたイオンピームエッチングできる。この時、PIQ版がエッチングできると関係にマスングでは、ので、変にがが減少する(第2回(3))。
こので、カオトレジストもPIQも同時にエッチングされるので、フオトレジストもPIQも同時にエッチングされるので、フォトレジストもPIQも同時にエッチングを映り、絶縁膜の選20の深さよりも以く形成して、イオンピームエッチング後にもフォトレジストが絶縁膜2上

特開昭63-113812 (4)

この時、マスク材としてフォトレジストのみを使うと、エツチング中にフォトレジストの偶然も同時にエツチングされるため、絶敏酸 2 中の間 2 0 の断面形状は第 2 図(4)に示すようにテーパのついた形状となる。したがつて、高密度のコイルを形成するには困難である場合を生じる。すなわち、高密度コイルパターンを形成する場合は、隣接する器どおしがつながつてしまうこともある。

そこで、絶数膜の斯面形状のテーパ角を立てることにより、高密度コイルを形成するためには、フオトレジストをマスクとするだけでなく、金成膜をマスクとして絶縁膜2をエッチングする方法が良い。第3回にその一例を示す。第3回(1)の絶縁限上に金属膜14を形成し、その上にフォトレジストパターン3を形成する。第3回(2)に示すようにこのフオトレジストパターンをマス

膜4を形成する。

この下地頤上の導体金属例えば C u を覚気めつきする。 C u の他、 A u 、 N i であっても良い。 金属膜 5 形成の時、このめつき 関 4 (C u 膜)のつきまわりにより P I Q の 複 2 O の 段 差 に 比較

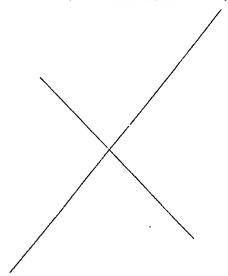
クとして、位初にマスクとする金属既14をエッチングする。絶縁既2をドライ法でエッチングするための、O2 ガスを用いたイオンビームエッチング 次を 川いることが、パターン 材度を良くする ために 有効な力 決である。この時のマスク材としての 金属版14としては、 耐酸 満イオンビームエッチング性の高いクロム、モリブデン、ニッケル等。各種の金属を用いることができる。

このように金属 映パターンを形成した後、第3 図(3)のように O。 ガスイオンピームエッチン グ弦を用いて、 絶験 膜に 牌 2 O を形成し、 その後、 飛存したフォトレジスト及びマスク材の金原 膜を 験去することにより、 第3 図(4) に示すように 絶数 膜上に 牌を形成する。

大に、第4関に示すように、PIQ上に形成された脚の中にコイルを形成する。

電気めつき法でコイルの金属腹を形成する方法 について述べる。第4回(1)に示すように、源 を形成したPIQから絶練膜上全面にめつき下地

してめつき膜表面5の凹凸を小さくすることができる。次に、このめつき膜全体をエッチバックする。すなわち、第4図(3)に示すように、絶数層表面23が現われるまで金属全面をエッチングし、コイルの相互間が絶縁され、また、表面が平坦化されるようにする。最後にPIQ膜を表面に形成し、コイルパターンの形成を終わる。この時、



特開昭63-113812 (5)

コイル上間の絶縁版23との間が平地化されているので、上部に形成したPIQの設面は平地に形成され、複工器でその上に形成される磁性膜の磁気特性の劣化を防止することができる。

第4回(3)に示したエツチバック鉄について 以下に説明する。

さらに第7回(3)に示すように、絶数膜23が 没面に見われるまで研摩することにより、コイル パターン24を完成することができる。この方法 によれば、ドライ法等の真空装置を用いることに よる工程数の増加及び製造コスト高をさけること ができるという効果がある。

以上述べた本実施例では、粒糠散2として有機 観顧を用いた例を述べたが、間様に脚を形成する エンチング条件及びエンチバンクに用いられるエ ツチング方法を選定することにより無機機を用い ることができる。

第4回に示したように、金瓜膜5の形成法としては電気めつき狭を用いたが、他の方法も可能である。例えば、第8回に示すように、化学めつき 法で金瓜膜5を形成して、導体コイル24を形成 することが可能である。

郊 B 図(1)に示すように、牌20を形成した 絶数膜2の設面全体に化学めつき膜を形成するための活性化処理をほどこす。この処理の一例を次 に示す。 まれたコイルの設面を平角に作ることができる。 この時、強布した有機樹脂の平坦性をそのままコ イル形成まで転写するには、有機樹脂と金属殿と のエンチング選度を関等にすることが良い。

明えば、金属股としてCuを用い、絶熱股としてPIQを用いたエツチング速度について説明する。第6 関には、イオンピームエツチング法、反応ガスとしてアルゴンと検索の混合ガスを用いた場合のCuとPIQのエツチング速度の発を示す。

第6 図によれば、酸素量が増すに従い、PIQのエッチング速度が増加し、Cuのエッチング速度が増加し、Cuのエッチング速度とを一定とすることができる。このような条件を選定することにより、エッチバック後の設而を平坦にすることができる。

エンチバック法以外の他の方法として、機械的 に研摩する方法も考えることができる。例えば、 第7日(1)に示すように、設面の凹凸のある金 扇面でも、装板裏面を研摩することにより、第7 図(2)に示すように金属服製面を平均にでき

SnCl₂・2 H₂O 4 0 g / g H C l 2 0 m l / l の溶版に 2 分 間 設 し た 後 、

PdC42·2 N2O 0.4 g/4
HC8 4 m 4/4

の溶液に2分間被すことにより、絶縁膜2の裂面 全面にPd25を折出させる。ここでは、Pdを 折出させる活性化処理をしたが、他にAu、Ag, Ptなどの企属を用いることができる。

このようにして活性化処理をほどこした基板を化学類めつき被中に設すことにより、活性化処理のほどこされた絶縁脱表面全面に解めつき膜5を形成することが可能である。もちろん化学解めつきだけでなく、化学めつきできる金属であれば、解に限らず金、ニッケル等のどんな金属を用いることも可能である。

特開昭63-113812 (6)

また、他の方法として、前記したとおり、真空 悪君法やスパッタリング法を用いる方法がある。 この方法を用いた場合、絶縁既装而の凹凸は、上 記しためつき法の場合のようには小さくならない ので、エッチパック法としては、第5回で示した ように有機材脂で平坦化する方法を採ることが望ましい。

(発明の効果)

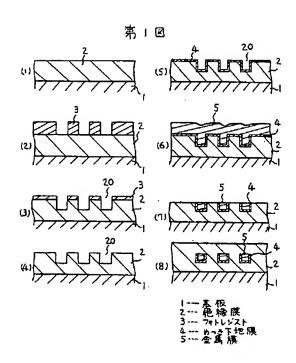
本発明によれば、辞談磁気へかどの高密度の間になれば、辞談磁気へかどの高密度の間に、辞談は、記録をいることにはなるのを助止することによってである。とによっての情報性の低下を防止するととができるので、後ことができるのでは、ないのとに形成する。とともに、確とは気へかどの特性の向上を造成できるという効果を存する。

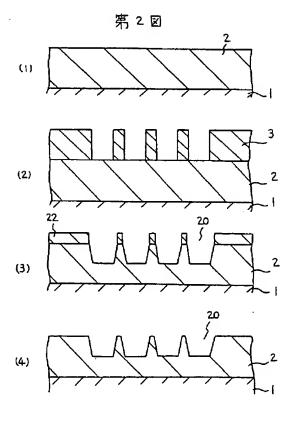
4、 歯面の簡単な説明

節 1 図は本発明にかかる際膜磁気ヘツドの製造

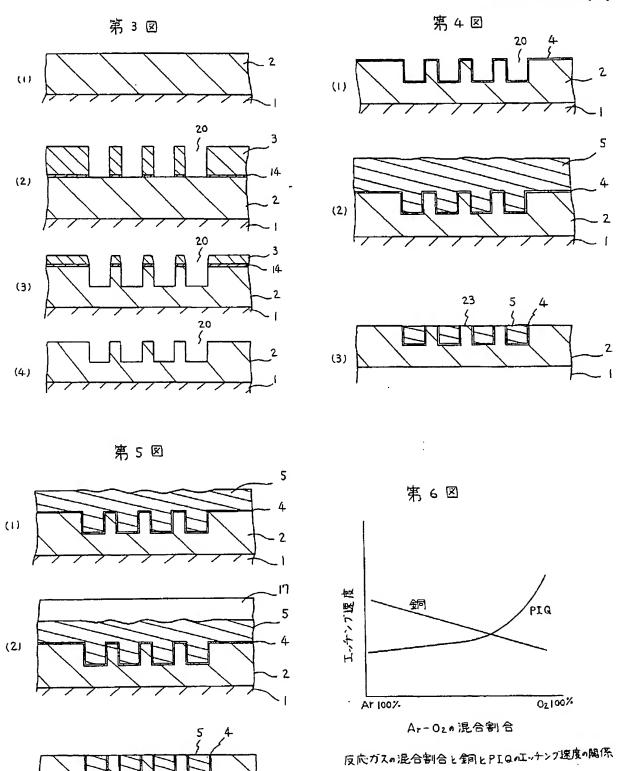
方法の一袋庭例を示す概略工程図、第2 関ないし第6 図は本発明にかかる部膜磁気ヘッドの製造方法の具体的突旋例を示す工程図、第6 図はA r ー O 2 の機合制合と絶縁膜のエッチング速度との関係を示すグラフ、第7 関は本発明にかかる解膜磁気ヘッドの製造方法の具体的突旋例を示す工程関である。1 … 基板、2 … 絶縁膜、3 … フォトレジスト、4 … めつき下地膜、5 … 金属膜。

代班人 弁理士 執削反之

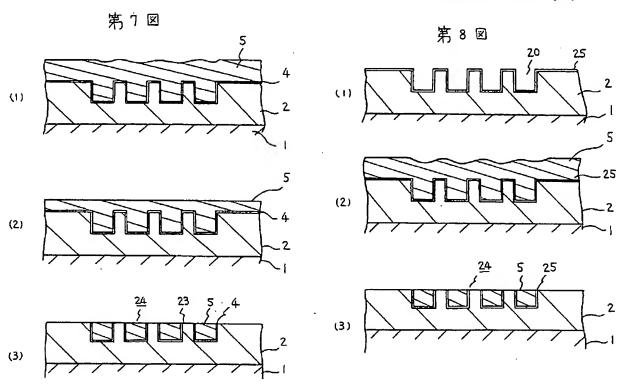




特開昭63-113812 (7)



特開昭63-113812 (8)



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Machine Translation of JP 2588392 B2 (equiv. 63-113812 A)

Detailed description of the invention. The this (the utilization field on the industry] invention concerns the production technique of a thin film magnetism $\sim \mathcal{Y} \mathcal{F}$, and especially, the formation of coil and insulating film of a thin film magnetism ヘッド is concerned. A thin film magnetism ヘッド for the magnetism デイスク equipment in [conventional technology] convention forms the conductor coil by the & method in order to describe from day sutra electronics, July seventh, 1980, 110 pages to 111 pages, and it has been formed in the result of doing heat curing of フオトレジスト which the insulating film was organic It is necessary to form the high-density coil at limited part it achieves the high-density magnetic recording in such thin film magnetism ヘッド for the magnetism デイスク equipment. minute structure in which for example, the distance of the space division of each volume of the multivolume coil becomes 2 μ m or less is necessary in order to achieve the high density of the coil.

In case of this composition, since the result of stiffening フオトレジスト as an insulating film is used,the resin is filled in space division formed between each coil volume by property such as the resinoid heat flow kinesis, and a thin film magnetism ヘツド is constituted. However, there is a problem with the bad heatresistance on the film which stiffened フオトレジスト. using the polyimide system resin are eye 1 - 1 - 1 - 1 = 1トランザクションオンマグネチツクス, エムエージー 15, 1616th page ~ 1618th page as an insulating film in which the heat-resistance is improved (1979). (IEEE Trans. Magn, MAG-15, 1616 \sim 1618 (1979)) <<Unparseable Text>>becomes the difficulty that the technology fills the polyimide system resin that there is no bubble between space of the coil and that it is an insulating layer without doing the consideration for the densifying of the coil, when however, this inventors examined it [the problem in which the invention intends to reach solution), superscription convention,. The resinoid fluidity is due to be bad. Though it was done, by introducer and bubble in the insulating layer by the filling remainder, the problem of lowering the reliability of magnetism ヘッド is あった. And, that it comes out as it is in order to form the insulating layer in coil and between coils, the ruggedness of the insulating layer which makes level difference of the coil to be causing on the surface of formed insulating layer, occurs, and the degradation of the magnetic characteristic of magnetic film besides, it forms at the department

Though it was done, the process of flattening the surface in the technology introducer superscription convention is required, and there is a problem that the process becomes the The purpose of this invention is to offer the method complexity. in which that the reliability is high by the insulating layer surely filling between coil lines, and again, that it produces got thin film magnetism ヘッド by the simple process is possible. Aforesaid フォトレジス this invention forms the insulating film on the substrate in order to achieve [means for solving the problem superscription purpose, and the photoresist of conductor coil of the fixed shape and identical pattern is formed on the aforesaid insulating film, and the aforesaid photoresist is made to be the mask material, the groove of aforesaid conductor coil and identical pattern is formed on this insulating film by the dry etching h is removed, and metal film is formed by the plating in the full face on aforesaid insulating film of the aforesaid groove, and the conductor coil of the fixed shape is formed in the groove by the removal of the metal film except for the groove in respect of the surface of the aforesaid metal film, and it is the production technique of thin film magnetic head which forms the second insulating film on aforesaid insulating film with the this conductor coil. According to the this [action] invention. after the groove of conductor coil and identical pattern was formed on the insulating film, the photoresist is removed, and metal film is formed by the plating in the full face on aforesaid insulating film of this groove. Afterwards, it is possible that it removes the metal film except for the groove by polishing the surface of the metal film by etchback methods, etc., and simply makes the thin film magnetic head in which therefore, there is no bubble in insulating film between coils this fixed conductor coil would. while the surface is flattened. Of the in addition, magnetic film in forming the second insulating film in the insulating film surface, after the conductor coil is formed, because to easily flatten the surface by the removal of metal film except for the groove is possible, that that the surface of apply second insulating film is also made to be the flat surface where there is hardly the ruggedness is possible and that it forms it by the next process in the top. It is possible to keep characteristics to the good thing. Using [practical example] drawing, practical example which concerns this invention is explained. figure showed the summary of the process on the formation of the conductor coil in this invention. In the figure, the sectionalview of magnetism $\sim \mathcal{Y} \mathrel{\mathsf{F}}$ is shown. Still, magnetic film formed on the description and substrate, etc. was supposed to be included for

substrate of 1 on the drawing, and it showed the insulating layer that conductor coil and conductor coil were embedded. follows next order. (1) Insulating film of 2 are formed on substrate of 1 at the fixed film thickness (first figure (1)). (2) フオトレジストパターン 3 are formed on insulating films of 2. It is possible to use organic resin or inorganic film as this insulating film (first figure (2)). In making (3) フオトレジストパターン3 to be the mask material, grooves of 20 is formed on insulating films of 2 by the dry-method (first figure It is formed so that this groove may become a pattern which is identical with the pattern of the conductor coil. possible to make grooves of 20 to be a form (size, height. thickness, etc.) of the desire by フオトレジスト and the エツチング. Though it is also possible mechanical grooves 20, in it, it is not sufficient, when the minuteness forms the pattern. The エツチング processing is desirable generally よ introducer. (4) フオトレジスト is removed in the peeling liquid (first figure 2 surfaces full face (first figure (5)). (6) Metal films of 5 which become the full face by the & method with the conductor coil are formed (first figure (6)). By this, the ruggedness of the surface becomes small in comparison with the ruggedness of the insulating film with forming the metal film of grooves of 20 in all on insulating film, and is flattened. It is based that metal film of 5 are formed in the full face on next reason. Though it is also possible grooves 20 metal film, it is difficult generally. metal film was formed in the full face in order to describe later, and the coil pattern would be formed by the removal of this metal film by what is called エツチバツク method. (7) This full face is removed to the insulating layer formation part in エツチバツク. Again, by the removal of the junction minute of the conductor formed in the upper part in the groove, each between conductors connect it in the metal film, and there would not be an introducer, and the coil pattern is formed (first figure (7)). conductor coil making process is finished by the formation of insulating films of 21 (first figure (8)). Entrainments of the bubble based on the resinoid fluidity bad, etc. can be prevented, since according to the above process, Led between metal films (between coils) do not fill the resin in め つき, and since it has formed the metal film in grooves of 20. The next concrete practical example is explained. The second figure shows the practical example which formed polyimide system resin which is organic resin on substrate of 1 as insulating film of 2 (second figure (2)). As a polyimide system resin, PIQ (polyimide

isoindolo quinazolinedione trade name, HITACHI formation Co., Ltd.) was used. Next, the groove which forms the coil using the drymethod is formed. Techniques such as プラズマエツチング method and イオンビームエツチング method are raised dry-methods here. either method, the pattern width is also also narrowed further than the case of chemistry エツチング method done エツチング using the solution, and it is unique that that the coil is formed in the high density, because to form and, deeply is possible, is possible. Second figure (1) has formed the insulating film which changes from PIQ on substrate of 1. Next, フオトレジストパターン 3 are formed, as it is shown in (2). Thereupon, as used フオトレジスト, in the cross-sectional shape of this フオトレジストパターン, because the pattern accuracy is good, it is possible to use マイクロポジツト 1300 (trade name, ジプレイフアースト Co., Ltd.) which are ノボラツク system positive フオトレジスト, and it becomes a trapezoid in which it is wide the width of that it is close to insulating film of 2 surfaces. In making to be masking フオトレジストパターン 3 formed by doing like this, エツチング of PIQ is done by the dry-method. As this time エツチング method, by stabilizing the pattern accuracy well, イオンビームエツチング using the 02 gas is possible エッチング. This time, height and width decrease, because エツチング of フオトレジスト used as a mask material is also done on doing エツチング of a PIQ film, (second figure (3)). By forming the film thickness in the beginning of フオトレジスト than the depth of insulating film of grooves of 20, because simultaneously, エツチング of フオトレジスト and PIQ is also done, deeply, it is made to be the film thickness in which フオトレジスト also is made to remain after イオンビームエツチング on insulating film of 2. It continues, only フオトレジスト 22 are removed in the フォトレジスト peeling liquid, and grooves of 20 which forms the coil on insulating films of 2 is formed (second figure (4)). This time, it becomes a shape in which the taper was given, as the cross-sectional shape in insulating film of 2 of groove of 20 is shown in second figure (4), when only フオトレジスト is used as a mask material, since simultaneously, エツチング of the sidewall of フオトレジスト is done in エツチング.

It was done, and it 生ずるs in order to form introducer and high-density coil, difficult。 that is to say, つなぐing つて adjoining groove どおし also has こと, when the high-density coil pattern is formed, しまう. Then, by making the taper angle of the cross-sectional shape of insulating film, in order to form the high-density coil, it is made to be masking the metal film フオトレジスト, and the method for doing エツチング of insulating

The example is shown in the third figure. films of 2 is good. Metal film of 14 are formed on the insulating film of third figure (1), and フオトレジストパターン 3 are formed in the top. In making to be masking this フオトレジストパターン, as it is shown in third figure (2), first エツチング of metal films of 14 as a mask is It is the method in which to use イオンビームエツチング method using the 02 gas for doing エツチング of PIQ which is the organic film, when エツチング of insulating films of 2 is done by the dry-method, is effective in order to improve the pattern As metal films of 14 as this time mask material, it is possible to use various metals such as chromium, molybdenum, ニッケル of which acidproof element イオンビームエッチング-ness is The groove is formed on the insulating film, as it is shown by by using 02 ガスイオンビームエツチング method like third figure (3) after it formed the metal film pattern like this, it forms grooves of 20 in insulating film, and removing remained フオトレジスト and metal film of the mask material afterwards in third figure (4). Next, the coil is formed in the groove formed on PIQ, as it is shown in the fourth figure. The method for forming the metal film of the coil by the electricity & method is Backing film of 4 with \(\mathcal{B} \) is formed from PIQ which formed the groove in the full face on insulating film, as it is shown in fourth figure (1). A backing film with め is established, and the adhesion between PIQ and metal film as a conductor coil is bad, and the metal film is made to bond together through a plating backing film in PIQ. This plating backing film is formed by for example, it deposits using the sputtering technique for example, Cr PIQ (substrate) evaporation method, and for example, it deposits using the sputtering technique next, Cu Cr evaporation method. PIQ is bonded together by Cr with Cu this time, and and, it is for bonding Cr together with the metal film as a conductor coil. possible to use besides besides former Cr as a thing within a plating backing film Ti, Ni, Mo, Ta, etc.. And, it is possible to use besides besides Cu Ni, Au, etc. within a plating backing film as a result with latter. Conductor metal on this plating backing film, for example electricity め つき of Cu, is done. It may be besides besides Cu Au, Ni. It is possible to make the ruggedness of the surface metal films of 5, namely metal film of 5 in plating film formation by attachment circumference of this film (a Cu film) with \varnothing compared to the level difference of PIQ of grooves of 20, Next, the etchback of this whole film with & is done. That is to say, the metal full face is etched, as it is shown in fourth figure (3), until insulating layer surface of 23 appears, and the mutual relation of the coil is insulated, and the surface

Finally, a PIQ film is formed on the surface. would be flattened. and it ends in respect of the formation of the coil pattern. time, the surface of PIQ formed in the upper part is flatly formed, because the interval between coil upper surface and insulating layer surface of 23 is flattened, and it is possible to prevent the degradation of the magnetic characteristic of magnetic film formed by the post-process in the top. エツチバツク method shown in fourth figure (3) is explained in the following. As エツチバツク by the dry-method, スパツタエツチング method or イオンビームエツチング method are used. The エツチバツグ method is to decline by doing エツチング of the full face, when the metal film surface was formed, until it is flattened, as it explained in the fourth figure. However, it is necessary to form the metal film deeply in order to form the metal film, until metal film of 5 surfaces are flattened. As the method that does not thicken and pays the metal film, there is a method for showing in the fifth figure. That is to say, the ruggedness of metal film of 5 surfaces is possible to flatly make the surface of the coil embedded in the insulating film, as it is shown by flattening the full face in order to show in fifth figure (2), in making organic resin of 17 of which the fluidity is also good for the top on あって, as it is shown in fifth figure (1), layered, and doing エツチバツク of the full face afterwards in fifth figure (3). This time, it is good that the エツチング speed between organic resin and metal film is done equivalent in order to copy the flatness of applied organic resin as it is to the coil making. For example, the エツチング speed using PIQ is explained using Cu as a metal film as insulating In the sixth figure, the difference in argon and Cu in using the mixed gas of the oxygen and エツチング speed of PIQ is shown as イオンビームエツチング method, reactant gas. According to the sixth figure, it is possible that the エツチング speed of PIQ increases, as the oxygen content increases, and that it does it with that it is constant in respect of Cu and エツチング speed of PIQ by the エツチング speed of Cu lowering. By selecting such condition, it is possible to flatten the surface after エツチバツク. As a method besides the except for エツチバツク method, it is possible to also consider the method for mechanically polishing. For example, the metal film surface can be flattened, as it is shown by polishing the substrate surface even in the metal surface with the ruggedness of the surface, as it is shown in seventh figure (1), in seventh figure (2), and it is possible to complete conductor coil of 24 by polishing, until insulating layer surface of 23 appears, as in addition, it is shown in seventh figure (3). According to this method, it is effective that to

avoid increase and manufacturing cost high of the process number by using vacuum devices such as the dry-method, is possible. in this practical example which described the above, the example using organic resin was described as insulating film of 2, it is possible to use the inorganic film by selecting エツチング condition for similarly forming the groove and エツチング method for エツチバツク. Though the electricity め method was used as a formation method of metal film of 5, as it was shown in the fourth figure, other method is also possible. For example, it is possible that conductor coil of 24 is formed by forming metal films of 5 by the chemistry め method, as it is shown in the eighth figure. The activation for forming a film with chemistry & in whole surface of insulating films of 2 which formed grooves of 20, as it is shown in eighth figure (1), is conducted. Next example of this processing will be shown. SnCl2 · 2H2O 40g/■HCl PdCl2 · 2H2O it was soaked in 20ml/■ solution during halves 0.4g/■HCl Surface full face of insulating films of 2 is made to deposit Pd25 by soaking in 4ml/■ solution during halves. Here, though the activation which deposited Pd was done, it is possible to use metals such as Au, Ag, Pt otherwise. By soaking the substrate which conducted the activation by doing like this, in submerged with chemistry copper め, it is possible to form film of 5 with copper め in insulating film surface full face that the activation was conducted. also possible to use gold it limits limit and what kind of metals such as ニッケル for the copper, if it is the metal which is not only chemistry copper め つき of course but also chemistry め つき.

According to this method, it is possible that that it comes out at what kind of part, if it does not need to form the terminal to for give the electricity on the substrate like electricity めっき, and if the activation is done, also forms the conductor coil. there is a method using vacuum deposition formula and スパツタリング method as other method, when it was written in advance. It is desirable that the method to for flatten in the organic resin is taken, as it was shown in the fifth figure as a エツチバツク method, because it does not decrease like the case in which this method was used and case of the method the ruggedness of the insulating film surface 溜める. According to the this effect of the invention] invention, it is possible to prevent the lowering of the reliability of magnetism ヘッド and よ introducer in preventing that the bubble is taken in in the insulating film between coils, when high-density conductor coil of a thin film magnetism $\wedge \mathcal{V}$ \mathbb{F} is formed,. In addition, it has the effect that the characteristic improvement of a thin film magnetism ヘッド in

which that the degradation of the magnetic characteristic of magnetic film formed in the top is prevented possibly got dense and improvement in the reliability can be achieved by the post-process by the simple process, because to also make the ruggedness of the surface of the insulating film formed on the coil small is possible. $4 \cdot 7$

Machine Translation of JP 2588392

DETAILED DESCRIPTION

[Detailed Description of the Invention] [Industrial Application] this invention relates to the manufacture method of the thin film magnetic head, especially relates to the coil of the thin film magnetic head, and formation of an insulator layer. [Description of the Prior Art] conventional thin film magnetic head for magnetic disk units is described by 111 pages from the Nikkei electronics, the July 7, 1980 issue, and 110 pages -- as -- a conductor -- a coil is formed by the galvanizing method, it is what heat-hardened and the photoresist which is an organic resin about an insulator layer is formed In such the thin film magnetic head for magnetic disk units, in order to attain high-density magnetic recording, it is necessary to form a high-density coil in the limited portion. In order to attain the high density of a coil, the detailed structure where the distance of the space section of each volume of the coil of many volumes is set to 2 micrometers or less is required. Since what stiffened the photoresist as an insulator layer is used in this composition, the space section formed between coil each volume is filled up with a resin by properties, such as the heat flow rate kinesis of the resin, and the thin film magnetic head is constituted. However, the film which hardened the photoresist has the problem that thermal resistance is bad. The example using the polyimide system resin as an insulator layer which thermal resistance is IEEE and a transaction. ON It is shown MAGUNECHITSUKUSU, em EJI 15, and 1616th page - the 1618th page (IEEE Trans.Magn, MAG-15, 1616-1618 (1979)) (1979). [Problem(s) to be Solved by the Invention] However, when this invention persons inquire, consideration of as opposed to the densification of a coil in the above-mentioned conventional technology is not carried out, but it becomes difficult to be filled up with the polyimide system resin which is an insulating layer that there is no foam between the spaces of a coil. It is because the fluidity of a resin is bad. Therefore, the problem of falling the reliability of the magnetic head with the foam in the insulating layer by the restoration remainder is ******. Moreover, in order to form an insulating layer between coils, the irregularity of the insulating layer which considers the level difference of a coil as a cause arises on the front face of the formed insulating layer, and if it remains as it is, degradation of the magnetic properties of the magnetic film formed in the upper part is caused. Therefore, with the above-mentioned conventional technology, the process which carries out flattening of the front face is needed, and there is a problem that a process becomes complicated. When an insulating layer can be certainly filled up between coil lines, the purpose of this invention is reliable and is to offer the method that the thin film magnetic head by which densification was carried out can be manufactured at a simple process. [The means for solving a technical problem] The photoresist of the same pattern as a coil is formed. in order to attain the abovementioned purpose -- this invention -- a substrate top -- an insulator layer -- forming -- the aforementioned insulator layer top -- the conductor of a predetermined configuration -- The slot of the same pattern as a coil is formed, the aforementioned photoresist -- mask material -carrying out -- the dry etching method -- the insulator layer top concerned -- the above -- a conductor -- Remove the aforementioned photoresist and a metal membrane is formed by the galvanizing method the whole surface on the aforementioned insulator layer including

aforementioned Mizouchi. the front face of the aforementioned metal membrane -- the etchback method or grinding mechanically -- metal membranes other than Mizouchi -- removing --Mizouchi -- the conductor of a predetermined configuration -- a coil -- forming -- the conductor concerned -- it is the manufacture method of the thin film magnetic head which forms the 2nd insulator layer on the aforementioned insulator layer which has a coil [Function] according to this invention -- an insulator layer top -- a conductor -- after forming the slot of the same pattern as a coil, a photoresist is removed and a metal membrane is formed by the galvanizing method the whole surface on the aforementioned insulator layer including the Mizouchi concerned then -- while removing metal membranes other than Mizouchi and carrying out flattening of the front face by grinding the front face of the metal membrane by the etchback method etc. -- the Mizouchi concerned -- the conductor of a predetermined configuration -- a coil is formed. therefore the thin film magnetic head which does not have a foam into the insulator layer between coils can be created easily furthermore -- since metal membranes other than Mizouchi can be removed and flattening of the front face can be easily carried out by grinding by the etchback method etc. -- a conductor -- the front face of the 2nd insulator layer applied [after forming a coil] for forming the 2nd insulator layer in the insulator layer front face can also be used as the flat front face which does not almost have irregularity, and can maintain at a good thing the property of the magnetic film formed on it at the following process [Example] The example concerning this invention is explained using a drawing. a conductor [in / this invention / in a view 1] -- the outline of the process about formation of a coil is shown The cross section of the magnetic head is shown in drawing. in addition -- that by which the magnetic film currently formed on explanation and the substrate is contained in the substrate 1 on a drawing -- carrying out -- a conductor -- a coil and a conductor -- the insulating layer where a coil is embedded is shown A process follows in the following order. (1) Carry out predetermined thickness formation of the insulator layer 2 on a substrate 1 (view 1 (1)). (2) Form the photoresist pattern 3 on an insulator layer 2. An organic resin or an inorganic film can be used as this insulator layer (view 1 (2)). (3) Make the photoresist pattern 3 into mask material, and form a slot 20 on an insulator layer 2 by the dry method (view 1 (3)). this slot -- a conductor -- it forms so that it may become the pattern of a coil, and the same pattern A slot 20 can be made into desired gestalten (a size, height, thickness, etc.) by the photoresist and its etching. Although a slot 20 can also be formed by mechanical processing, it is not enough when forming a detailed ** pattern then. Therefore, etching processing is usually desirable. (4) Ablation liquid removes a photoresist (view 1 (4)). (5) Form the plating ground film 4 all over insulator layer 2 front face (view 1 (5)). (6) the whole surface -- the galvanizing method -- a conductor -form the metal membrane 5 used as a coil (view 1 (6)) Thereby, while a metal membrane is formed [be / under / slot 20 / implication / it] in all on an insulator layer, the irregularity of the front face becomes small as compared with the irregularity of an insulator layer, and becomes flat. Forming a metal membrane 5 in the whole surface is based on the following reason. Although it can limit in a slot 20 and a metal membrane can also be formed, it is usually difficult. Then, the metal membrane was formed in the whole surface so that it might mention later, this metal membrane is removed by the so-called etchback method, and the coil pattern was formed. (7) Remove this whole surface to an insulating stratification portion by etchback. a part for and the connection of the conductor currently formed in the upper part of a slot -removing -- each -- a conductor -- between -- a metal membrane -- a rope -- ***** -- there is

nothing -- making -- a coil pattern is formed (view 1 (7)) (8) the conductor which carried out in this way and was formed -- a coil top -- an insulator layer 21 -- forming -- a conductor -- end a coil formation process (view 1 (8)) Since according to the above process you do not make it filled up with a resin between the galvanized metal membranes (between coils) but the metal membrane is formed in a slot 20, the contamination of a foam based on the fluid defect of a resin etc. can be prevented. Next, a concrete example is explained. A view 2 shows the example in which the polyimide system resin which is an organic resin as an insulator layer 2 was formed on the substrate 1 (view 2 (2)). As a polyimide system resin, PIQ (a polyimide ISOINDORO quinazoline dione tradename and Hitachi Chemical Co., Ltd.) was used. Subsequently, the slot which forms a coil using the dry method is formed. Here, with the dry method, technique, such as the plasma etching method and the ion-beam-etching method, is raised. Since pattern width of face can be narrowly formed deeply rather than the case of the chemical etching method which ******** also about which method using a solution, there is the feature that a coil can be formed with high density. The view 2 (1) forms the insulator layer which consists of PIQ on a substrate 1. Next, as shown in (2), the photoresist pattern 3 is formed. Since pattern precision is good, although micro POJITSUTO 1300 (a tradename, JIPUREI fast incorporated company) which is the photoresist of a novolak system positive type can be used as a photoresist used here, in the cross-section configuration of this photoresist pattern, the direction near insulator layer 2 front face becomes the latus trapezoid of width of face. Thus, PIQ is *******ed by the dry method by using the formed photoresist pattern 3 as a mask. The ion beam etching using O2 gas as a method of etching at this time has a good pattern precision, and can stabilize and etch. Since the photoresist used as mask material at the same time a PIQ film ******* at this time also ********, height and width of face decrease (view 2 (3)). Since it ******* simultaneously, a photoresist and PIQ form the original thickness of a photoresist more thickly than the depth of the slot 20 on the insulator layer, and make it the thickness which a photoresist makes remain on an insulator layer 2 also after ion beam etching. Then, photoresist ablation liquid removes only a photoresist 22 and the slot 20 which forms a coil on an insulator layer 2 is formed (view 2 (4)). If only a photoresist is used as mask material at this time, it will become the configuration where the taper also attached the side attachment wall of a photoresist during etching as the cross-section configuration of the slot 20 in an insulator layer 2 was shown in a view 2 (4) since it *******ed simultaneously. Therefore, the case of being difficult for forming a high-density coil is produced. That is, when forming a high-density coil pattern, adjoining slot entirety also has [a rope] intermediary striped *****. Then, in order to form a high-density coil by standing the taper angle of the cross-section configuration of an insulator layer, the method of it not only using a photoresist as a mask, but *******ing an insulator layer 2 by using a metal membrane as a mask is good. The example is shown in a view 3. A metal membrane 14 is formed on the insulator layer of a view 3 (1), and the photoresist pattern 3 is formed on it. The metal membrane 14 first used as a mask by using this photoresist pattern as a mask as shown in a view 3 (2) is ********ed. When *******ing an insulator layer 2 by the dry method, it is an effective method to use the ion-beam-etching method using O2 gas for membrane 14 as mask material at this time, various kinds of metals, such as high chromium of oxygen-proof ion-beam-etching nature, molybdenum, and nickel, can be used. Thus, by forming

a slot 20 in an insulator layer using the O2 gas-ion beam etching method, as shown in a view 3 (3), after forming a metal membrane pattern, and removing the metal membrane of the photoresist which remained after that, and mask material, as shown in a view 3 (4), a slot is formed on an insulator layer. Next, as shown in a view 4, a coil is formed into the slot formed on PIQ. How to form the metal membrane of a coil with electroplating is described. As shown in a view 4 (1), the plating ground film 4 is formed all over an insulator layer top from PIO in which the slot was formed. a plating ground film -- PIQ and a conductor -- since adhesion with the metal membrane used as a coil is bad, it prepares in order to paste up a metal membrane on PIQ through a plating ground film On PIQ (substrate), vacuum evaporationo is carried out, for example using the sputtering method, then this plating ground film forms Cu for Cr on Cr by [which is a vacuum deposition / which is a vacuum deposition] carrying out vacuum evaporationo, for example using the sputtering method. at this time, Cr pastes up PIQ and Cu -- making -- moreover, Cu -- Cr and a conductor -- it is for pasting up the metal membrane used as a coil Ti, nickel, Mo, Ta, etc. besides Cr can be used as a former thing among plating ground films. Moreover, nickel, Au, etc. besides Cu can be used as a latter thing among plating ground films. this plating ground film top -- a conductor -- a metal, for example, Cu, is electroplated You may be Au and nickel besides Cu. As compared with the level difference of the slot 20 on the PIQ, irregularity of the front face of a metal membrane 5 can be made small by the covering power of this plating film (Cu film) at the time of a metal membrane 5, i.e., plating film formation. Next, etchback of this whole plating film is carried out. That is, the whole metal surface is *******ed until the insulating-layer front face 23 appears, as shown in a view 4 (3), between coils is insulated, and flattening of the front face is made to be carried out. Finally a PIQ film is formed in a front face, and formation of a coil pattern is finished. Since flattening of between the coil upper surface and the insulating-layer front faces 23 is carried out at this time, the front face of PIQ formed in the upper part can prevent degradation of the magnetic properties of the magnetic film which is formed evenly and formed on it at a back process. The etchback method shown in the view 4 (3) is explained below. As etchback by the dry method, sputter etching or the ion-beam-etching method is used. The dirty bag method is *******ing and retreating the whole surface, after forming a metal membrane front face until it became flat as explained in the view 4. However, in order to form a metal membrane until metal membrane 5 front face becomes flat, it is necessary to form a metal membrane thickly. There is a method shown in a view 5 as a method which does not need to thicken a metal membrane. That is, as shown in the 5th view (1), the front face of the coil embedded at the insulator layer as by ******'s also carrying out laminating formation of the fluid good organic resin 17 on it, carrying out flattening of the whole surface as shown in a view 5 (2), and carrying out etchback of the whole surface after that showed to a view 5 (3) in the irregularity of metal membrane 5 front face can be made evenly. In order to imprint the flat nature of the applied organic resin to coil formation as it is at this time, it is good to make equivalent the etch rate of an organic resin and a metal membrane. For example, the etch rate using PIQ as an insulator layer is explained, using Cu as a metal membrane. The difference of the etch rate of Cu and PIQ at the time of using the mixed gas of an argon and oxygen as the ion-beam-etching method and reactant gas is shown in a view 6. According to the view 6, the etch rate of PIQ can increase, the etch rate of Cu can fall, and the etch rate of Cu and PIQ can be set constant as the amount of oxygen increases. By selecting such conditions, the front face

after etchback can be made flat. How to grind mechanically can also be considered as other methods other than the etchback method. for example, the thing polished until the insulating-layer front face 23 appears also in respect of a surface irregular metal as a metal membrane front face is made flat by polishing a substrate front face as shown in a view 7 (2), and further shown in a view 7 (3) as shown in a view 7 (1) -- a conductor -- a coil 24 can be completed According to this method, it is effective in the increase and manufacturing-cost quantity of the number of processes by using vacuum devices, such as the dry method, being avoidable. Although this example described above described the example which used the organic resin as an insulator layer 2, an inorganic film can be used by selecting the etching method used for the etching conditions and etchback which form a slot similarly. Other methods are possible although electroplating was used as a method of forming a metal membrane 5 as shown in the view 4. for example, it is shown in a view 8 -- as -- chemical plating -- a metal membrane 5 -- forming -- a conductor -- it is possible to form a coil 24

As shown in a view 8 (1), activation for forming an electroless plating film in the whole front face of the insulator layer 2 in which the slot 20 was formed is given. An example of this processing is shown below. SnCl2.2H2O 40g/**HCl PdCl2.2H2O after dipping in the solution of 20ml / ** for 2 minutes 0.4g/**HCl By dipping in the solution of 4ml / ** for 2 minutes, Pd25 is deposited all over the front face of an insulator layer 2. Here, although activation which deposits Pd was carried out, metals, such as Au, Ag, and Pt, can be used for others. Thus, by dipping the substrate which gave activation into chemistry copper-plating liquid, it is possible to form the copper-plating film 5 all over the insulator layer front face where activation was given. Of course, it is possible not only chemistry copper plating but to use what metals, such as not only copper but gold, nickel, etc., if it is the metal which is electroless plating.

if it is not necessary to form the terminal for giving the electrical and electric equipment on a substrate like electroplating according to this method and activation is carried out -- what portion -- a conductor -- it is possible to form a coil Moreover, as other methods, there is a method using a vacuum deposition method or the sputtering method as described above. When this method is used, since it does not become small like [in the case of the above-mentioned galvanizing method], as for the irregularity on the front face of an insulator layer, it is desirable to take the method of carrying out flattening by the organic resin as an etchback method, as the view 5 showed. [Effect of the Invention] according to this invention -- a conductor with the high-density thin film magnetic head -- in case a coil is formed, therefore, the fall of the reliability of the magnetic head can be prevented to prevent that air bubbles are incorporated between coils in an insulator layer Furthermore, since irregularity of the front face of the insulator layer formed on a coil can also be made small, degradation of the magnetic properties of the magnetic film formed on it at a back process can be prevented, and it has the effect that the improvement in the property of the thin film magnetic head and the improvement in reliability by which densification was carried out can be attained at a simple process.

CLAIMS

(57) [Claim(s)] [Claim 1] The photoresist of the same pattern as a coil is formed, a substrate

top -- an insulator layer -- forming -- the aforementioned insulator layer top -- the conductor of a predetermined configuration -- The slot of the same pattern as a coil is formed. the aforementioned photoresist -- mask material -- carrying out -- the dry etching method -- the insulator layer top concerned -- the above -- a conductor -- Remove the aforementioned photoresist and a metal membrane is formed by the galvanizing method the whole surface on the aforementioned insulator layer including aforementioned Mizouchi. the front face of the aforementioned metal membrane -- the etchback method or grinding mechanically -- metal membranes other than Mizouchi -- removing -- Mizouchi -- the conductor of a predetermined configuration -- a coil -- forming -- the conductor concerned -- the manufacture method of the thin film magnetic head which forms the 2nd insulator layer on the aforementioned insulator layer which has a coil

[Translation done.]